Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

239817US3

SERIAL NO.

10/628,532

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Eiji KURIMOTO, et al.

FILING DATE

July 29, 2003

GROUP

2852

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
h	AA	2002/0076633 A1	06/20/2002	T. NIIMI			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
h	AO	8-101524	04/16/1996	JAPAN (with English Abstract)		X
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

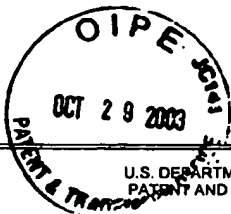
☐ Additional References sheet(s) attached

Examiner

Date Considered

10/5/04

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 239817US3		SERIAL NO. 10/628,532	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Eiji KURIMOTO, et al.			
				FILING DATE July 29, 2003		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
HS	AA	6,319,878	11/20/01	INA et al.			
HS	AB	5,339,138	08/16/94	MISHIMA et al.			
HS	AC	5,578,405	11/26/96	IKEGAMI et al.			
HS	AD	5,702,855	12/30/97	IKEGAMI et al.			
HS	AE	6,030,736	02/29/00	IKEGAMI et al.			
HS	AF	6,558,863	05/06/03	ROKUTANZONO et al.			
HS	AG	6,432,596	08/13/02	IKUNO et al.			
HS	AH	6,521,387	02/18/03	KAWASAKI			
HS	AI	6,573,016	06/03/03	KAMI et al.			
HS	AJ	6,618,565	09/09/03	TAMIYA et al.			
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO						
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
					<input type="checkbox"/> Additional References sheet(s) attached		
Examiner <i>John</i>					Date Considered 10/15/04		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

239817US3

SERIAL NO.

New Application

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Eiji KURIMOTO, et al.

FILING DATE

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## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
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	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						

## FOREIGN PATENT DOCUMENTS


		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
HT	AN	8-146641	6/7/96	Japan w/ English abstract		X
HT	AO	1-116677	5/9/89	Japan w/ English translation	X	
HT	AP	3-78782	4/3/91	Japan	X	
HT	AQ	8-314175	11/29/96	Japan	X	
HT	AR	9-288441	11/4/97	Japan	X	
HT	AS	1-205171	8/17/89	Japan w/ English abstract		X
HT	AT	7-333881	12/22/95	Japan w/ English abstract		X
HT	AU	8-15887	1/19/96	Japan w/ English abstract		X
HT	AV	8-123053	5/17/96	Japan w/ English abstract		X

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner



Date Considered

10/15/94

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